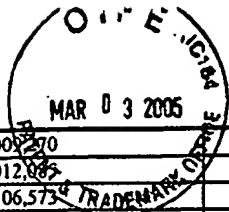




Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)			<i>Complete if Known</i>		
			Application Number	09/844,668	
			Filing Date	April 30, 2001	
			First Named Inventor	THEKKATH	
			Group Art Unit	2122-92	
			Examiner Name	Pham, Chrystine	
Sheet	1	of	2	Attorney Docket Number	MTEC-004/00US

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		Office ¹	Number ²	Kind Code ³ (if known)		
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CP	F2	GB	2 329 049		ARM Limited	10/03/1999

Examiner Signature		Date Considered	05/31/05
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Complete if Known			
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